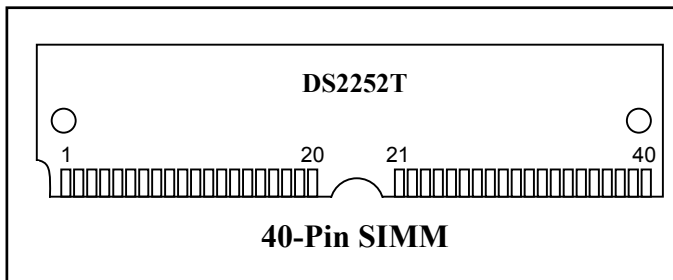


GENERAL DESCRIPTION

The DS2252T secure microcontroller module is an 8051-compatible microcontroller based on nonvolatile RAM technology. It is designed for systems that need to protect memory contents from disclosure. This includes key data, sensitive algorithms, and proprietary information of all types. Like other members of the secure microcontroller family, it provides full compatibility with the 8051 instruction set, timers, serial port, and parallel I/O ports. By using NV RAM instead of ROM, the user can program, then reprogram the microcontroller while in-system. This allows frequent changing of sensitive processes with minimal effort.

PIN CONFIGURATION



Operating information and detailed summary of this product's security features are contained in the Secure Microcontroller User's Guide. This data sheet provides ordering information, pinout, and electrical specifications.

ORDERING INFORMATION

PART	RAM SIZE (kB)	MAX CRYSTAL SPEED (MHz)	TIMEKEEPING?
DS2252T-64-16	64	16	Yes
DS2252T-64-16#	64	16	Yes
DS2252T-125-16	128	16	Yes
DS2252T-125-16#	128	16	Yes

Denotes RoHS-compliant device that may contain lead exempt under the RoHS requirements.

FEATURES

- **8051-Compatible Microcontroller**
8, 32, or 64kbytes of Nonvolatile SRAM for Program and/or Data Memory Storage
In-System Programming via On-Chip Serial Port
Capable of Modifying its Own Program and/or Data Memory in the End System
- **Firmware Security Features**
Memory Stored in Encrypted Form
Encryption Using On-Chip 64-Bit Key
Automatic True Random Key Generator
Self-Destruct Input (SDI)
Improved Security Over Previous Generations
Protects Memory Contents from Piracy
- **Crashproof Operation**
Maintains All Nonvolatile Resources Up to 10 Years in the Absence of V_{CC} at Room Temperature
Power-Fail Reset
Early Warning Power-Fail Interrupt
Watchdog Timer
Precision Reference for Power Monitor
- **Fully 8051 Compatible**
128 Bytes Scratchpad RAM
Two Timer/Counters
On-Chip Serial Port
32 Parallel I/O Port Pins
- **Permanently Powered Real-Time Clock**

DETAILED DESCRIPTION

The DS2252T provides an array of mechanisms to prevent an attacker from examining the memory. It is designed to resist all levels of threat including observation, analysis, and physical attack. As a result, a massive effort would be required to obtain any information about memory contents. Furthermore, the “Soft” nature of the DS2252T allows frequent modification of secure information. This minimizes that value of any information that is obtained.

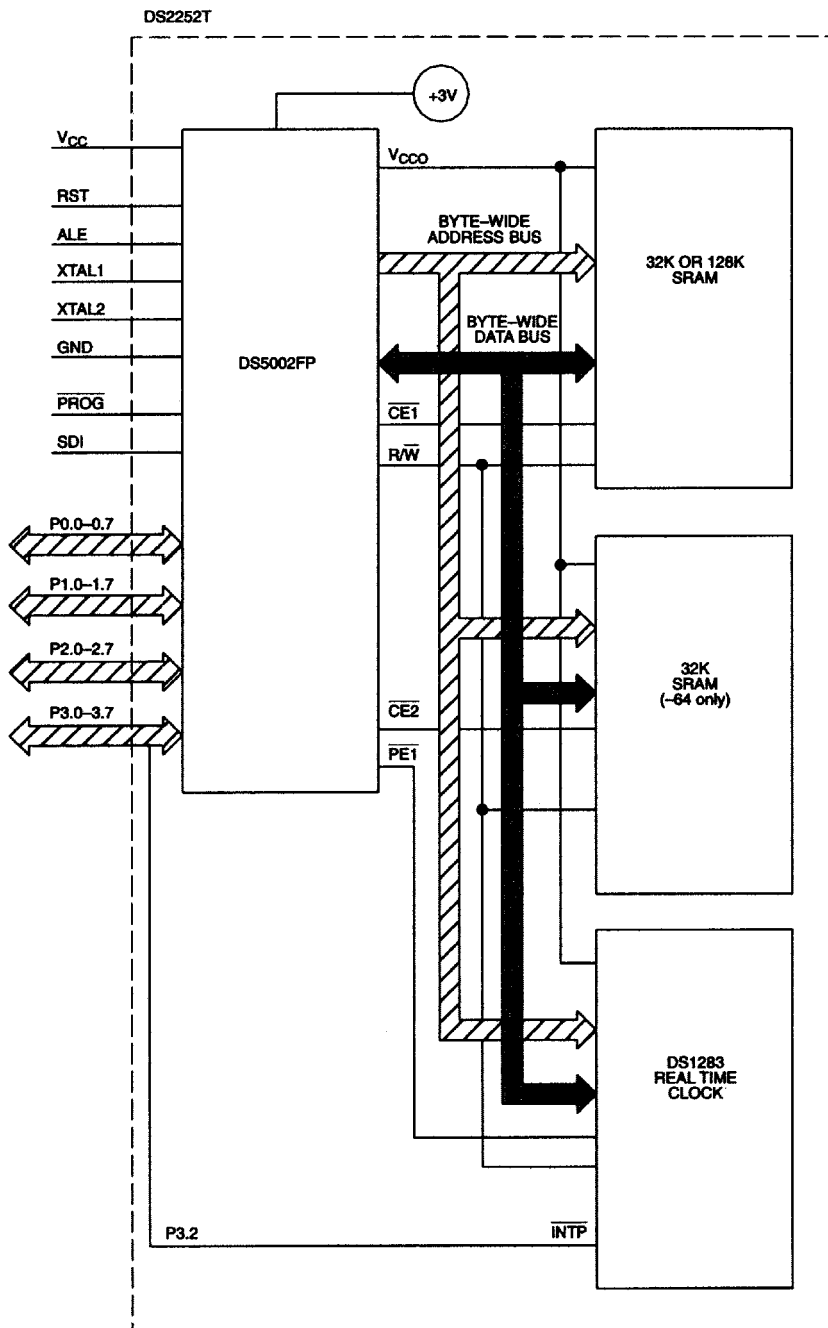
Using a security system based on the DS5002FP, the DS2252T protects the memory contents from disclosure. It loads program memory via its serial port and encrypts it in real time prior to storing it in SRAM. Once encrypted, the RAM contents and the program flow are unintelligible. The real data exists only inside the processor chip after being decrypted. Any attempt to discover the on-chip data, encryption keys, etc., results in its destruction. Extensive use of nonvolatile lithium-backed technology creates a microcontroller that retains data for over 10 years at room temperature, but which can be erased instantly if tampered with. The DS2252T even interfaces directly to external tamper protection hardware.

The DS2252T provides a permanently powered real time lock with interrupts for time stamp and date. It keeps time to one hundredth of a second using its onboard 32 kHz crystal.

Like other Secure Microcontrollers in the family, the DS2252T provides crashproof operation in portable systems or systems with unreliable power. These features include the ability to save the operating state, Power-fail Reset, Power-fail Interrupt, and Watchdog Timer. All nonvolatile memory and resources are maintained for over 10 years at room temperature in the absence of power.

A user loads programs into the DS2252T via its on-chip Serial Bootstrap Loader. This function supervises the loading of software into NV RAM, validates it, then becomes transparent to the user. It also manages the loading of new encryption keys automatically. Software is stored in onboard CMOS SRAM. Using its internal Partitioning, the DS2252T can divide a common RAM into user selectable program and data segments. This Partition can be selected at program loading time, but can be modified anytime later. The microcontroller will decode memory access to the SRAM, access memory via its Byte-wide bus and write-protect the memory portion designated as program (ROM).

DS2252T BLOCK DIAGRAM Figure 1



PIN ASSIGNMENT

PIN	NAME	PIN	NAME	PIN	NAME	PIN	NAME
1	P1.0	11	P1.5	21	P3.1/TXD	31	P3.6/ $\overline{\text{WR}}$
2	V _{CC}	12	P0.4	22	ALE	32	P2.4
3	P1.1	13	P1.6	23	P3.2/ $\overline{\text{INT0}}$	33	P3.7/ $\overline{\text{RD}}$
4	P0.0	14	P0.5	24	$\overline{\text{PROG}}$	34	P2.3
5	P1.2	15	P1.7	25	P3.3/ $\overline{\text{INT1}}$	35	XTAL2
6	P0.1	16	P0.6	26	P2.7	36	P2.2
7	P1.3	17	RST	27	P3.4/T0	37	XTAL1
8	P0.2	18	P0.7	28	P2.6	38	P2.1
9	P1.4	19	P3.0/RXD	29	P3.5/T1	39	GND
10	P0.3	20	SDI	30	P2.5	40	P2.0

PIN DESCRIPTION

PIN	DESCRIPTION
4, 6, 8, 10, 12, 14, 16, 18	P0.0 - P0.7. General purpose I/O Port 0. This port is open-drain and cannot drive a logic 1. It requires external pullups. Port 0 is also the multiplexed Expanded Address/Data bus. When used in this mode, it does not require pullups.
1, 3, 5, 7, 9, 11, 13, 15	P1.0 - P1.7. General purpose I/O Port 1.
40, 38, 36, 34, 32, 30, 28, 26	P2.0 - P2.7. General purpose I/O Port 2. Also serves as the MSB of the Expanded Address bus.
19	P3.0 RXD. General purpose I/O port pin 3.0. Also serves as the receive signal for the on board UART. This pin should <u>NOT</u> be connected directly to a PC COM port.
21	P3.1 TXD. General purpose I/O port pin 3.1. Also serves as the transmit signal for the on board UART. This pin should <u>NOT</u> be connected directly to a PC COM port.
23	P3.2 $\overline{\text{INT0}}$. General purpose I/O port pin 3.2. Also serves as the active low External Interrupt 0. This pin is also connected to the $\overline{\text{INTP}}$ output of the DS1283 Real Time Clock.
25	P3.3 $\overline{\text{INT1}}$. General purpose I/O port pin 3.3. Also serves as the active low External Interrupt 1.
27	P3.4 T0. General purpose I/O port pin 3.4. Also serves as the Timer 0 input.
29	P3.5 T1. General purpose I/O port pin 3.5. Also serves as the Timer 1 input.
31	P3.6 $\overline{\text{WR}}$. General purpose I/O port pin. Also serves as the write strobe for Expanded bus operation.
33	P3.7 $\overline{\text{RD}}$. General purpose I/O port pin. Also serves as the read strobe for Expanded bus operation.

PIN	DESCRIPTION
17	RST - Active high reset input. A logic 1 applied to this pin will activate a reset state. This pin is pulled down internally, can be left unconnected if not used. An RC power-on reset circuit is not needed and is <u>NOT</u> recommended.
22	ALE - Address Latch Enable. Used to de-multiplex the multiplexed Expanded Address/Data bus on Port 0. This pin is normally connected to the clock input on a '373 type transparent latch.
35, 37	XTAL2, XTAL1 . Used to connect an external crystal to the internal oscillator. XTAL1 is the input to an inverting amplifier and XTAL2 is the output.
39	GND - Logic ground.
2	V_{CC} - +5V.
24	PROG - Invokes the Bootstrap loader on a falling edge. This signal should be debounced so that only one edge is detected. If connected to ground, the microcontroller will enter Bootstrap loading on power up. This signal is pulled up internally.
20	SDI – Self-Destruct Input. A logic 1 applied to this input causes a hardware unlock. This involves the destruction of Encryption Keys, Vector RAM, and the momentary removal of power from V _{CC0} . This pin should be grounded if not used.

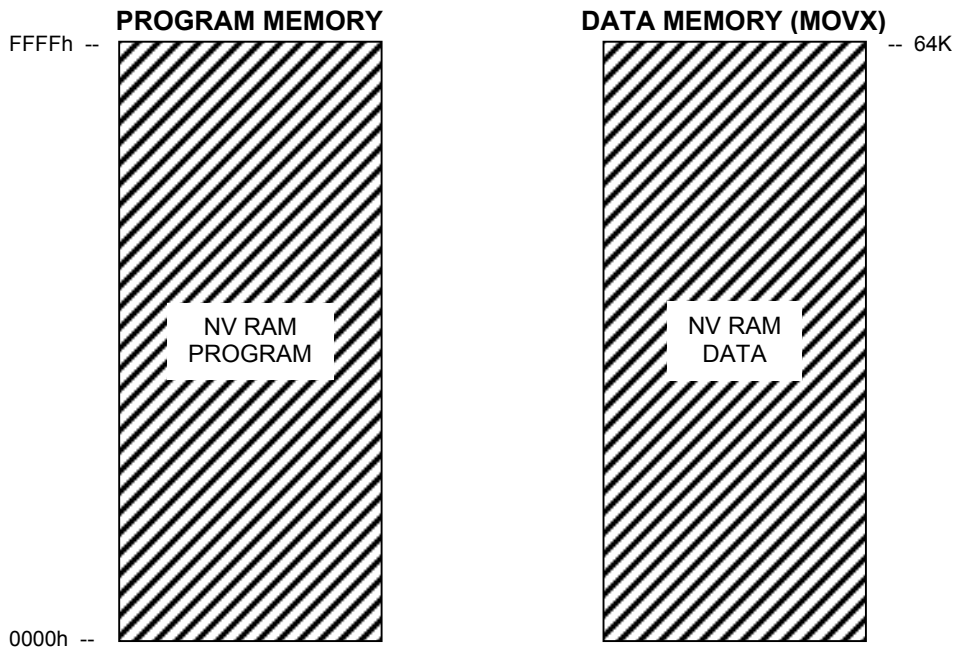
INSTRUCTION SET

The DS2252T executes an instruction set that is object code-compatible with the industry standard 8051 microcontroller. As a result, software development packages such as assemblers and compilers that have been written for the 8051 are compatible with the DS2252T. A complete description of the instruction set and operation are provided in the Secure Microcontroller User's Guide.

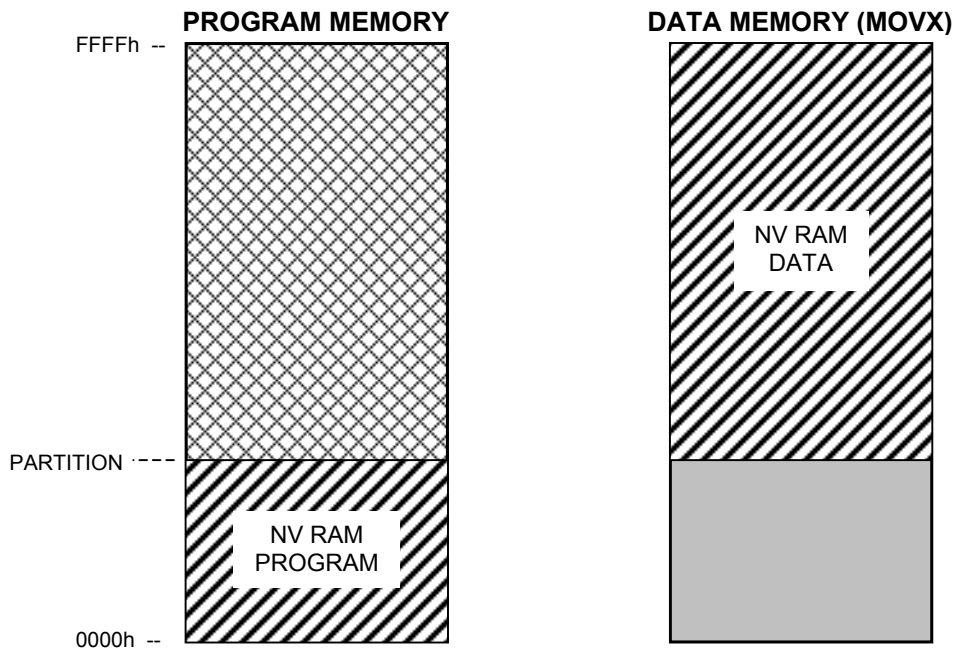
MEMORY ORGANIZATION

Figure 2 illustrates the memory map accessed by the DS2252T. The entire 64k of program and 64k of data are available to the Byte-wide bus. This preserves the I/O ports for application use. An alternate configuration allows dynamic Partitioning of a 64k space as shown in Figure 3. Any data area not mapped into the NV RAM is reached via the Expanded bus on Ports 0 and 2. Off-board program memory is not available for security reasons. Selecting PES = 1 provides access to the real-time clock as shown in Figure 4. These selections are made using Special Function Registers. The memory map and its controls are covered in detail in the Secure Microcontroller User's Guide.

DS2252T MEMORY MAP IN NON-PARTITIONABLE MODE (PM = 1) Figure 2



DS2252T MEMORY MAP IN PARTITIONABLE (PM = 0) Figure 3



NOTE: PARTITIONABLE MODE IS NOT SUPPORTED ON THE 128KB VERSION OF THE DS2252T.

LEGEND:



= NV RAM MEMORY

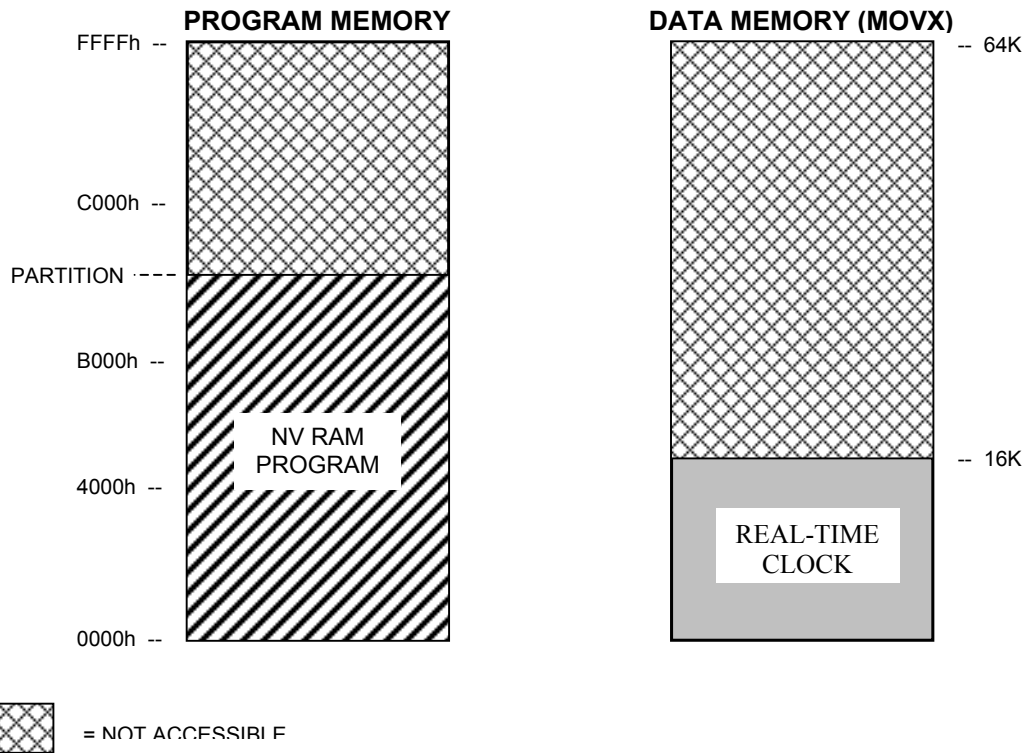


= NOT AVAILABLE



= EXPANDED BUS (PORTS 0 AND 2)

DS2252T MEMORY MAP WITH (PES = 1) Figure 4



POWER MANAGEMENT

The DS2252T monitors V_{CC} to provide power-fail reset, early warning power-fail interrupt, and switchover to lithium backup. It uses an internal band-gap reference in determining the switch points. These are called V_{PFW} , V_{CCMIN} , and V_{LI} respectively. When V_{CC} drops below V_{PFW} , the DS2252T will perform an interrupt vector to location 2Bh if the power-fail warning is enabled. Full processor operation continues regardless. When power falls further to V_{CCMIN} , the DS2252T invokes a reset state. No further code execution will be performed unless power rises back above V_{CCMIN} . All decoded chip enables and the R/\overline{W} signal go to an inactive (logic 1) state. V_{CC} is still the power source at this time. When V_{CC} drops further to below V_{LI} , internal circuitry will switch to the built-in lithium cell for power. The majority of internal circuits will be disabled and the remaining nonvolatile states will be retained. The Secure Microcontroller User's Guide has more information on this topic. The trip points V_{CCMIN} and V_{PFW} are listed in the electrical specifications.

ABSOLUTE MAXIMUM RATINGS

Voltage Range on Any Pin Relative to Ground.....	-0.3V to ($V_{CC} + 0.5V$)
Voltage Range on V_{CC} Relative to Ground.....	-0.3V to +6.0V
Operating Temperature Range.....	-40°C to +85°C
Storage Temperature (Note 1).....	-55°C to +125°C
Soldering Temperature.....	+260°C for 10 seconds

This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operation sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods of time may affect reliability.

Note 1: Storage temperature is defined as the temperature of the device when $V_{CC} = 0V$ and $V_{LI} = 0V$. In this state the contents of SRAM are not battery-backed and are undefined.

DC CHARACTERISTICS

($V_{CC} = 5V \pm 10\%$, $T_A = 0^\circ C$ to $+70^\circ C$.)

PARAMETER	SYMBOL	MIN	TYP	MAX	UNITS	NOTES
Input Low Voltage	V_{IL}	-0.3		+0.8	V	1
Input High Voltage	V_{IH1}	2.0		$V_{CC}+0.3$	V	1
Input High Voltage (RST, XTAL1, \overline{PROG})	V_{IH2}	3.5		$V_{CC}+0.3$	V	1
Output Low Voltage at $I_{OL} = 1.6mA$ (Ports 1, 2, 3)	V_{OL1}		0.15	0.45	V	1
Output Low Voltage at $I_{OL} = 3.2mA$ (Ports 0, ALE)	V_{OL2}		0.15	0.45	V	1
Output High Voltage at $I_{OH} = -80\mu A$ (Ports 1, 2, 3)	V_{OH1}	2.4	4.8		V	1
Output High Voltage at $I_{OH} = -400\mu A$ (Ports 0, ALE)	V_{OH2}	2.4	4.8		V	1
Input Low Current $V_{IN} = 0.45V$ (Ports 1, 2, 3)	I_{IL}			-50	μA	
Transition Current; 1 to 0 $V_{IN} = 2.0V$ (Ports 1, 2, 3)	I_{TL}			-500	μA	
Input Leakage Current $0.45 < V_{IN} < V_{CC}$ (Port 0)	I_{IL}			± 10	μA	
RST Pulldown Resistor	R_{RE}	40		150	k Ω	
Power-Fail Warning Voltage	V_{PRW}	4.25	4.37	4.50	V	1
Minimum Operating Voltage	V_{CCMIN}	4.00	4.12	4.25	V	1
Operating Current at 16MHz	I_{CC}			45	mA	4
Idle Mode Current at 12MHz	I_{IDLE}			7.0	mA	5
Stop Mode Current	I_{STOP}			80	μA	6
Pin Capacitance	C_{IN}			10	pF	7

DC CHARACTERISTICS (continued) $(V_{CC} = 5V \pm 10\%, T_A = 0^\circ C \text{ to } +70^\circ C.)$

PARAMETER		SYMBOL	MIN	TYP	MAX	UNITS	NOTES
Reset Trip Point in Stop Mode	With BAT = 3.0V		4.0		4.25	V	1
	With BAT = 3.3V		4.4		4.65		
SDI Input High Voltage		V_{IHS}	2.0		V_{CC}	V	1, 2
SDI Input High Voltage		V_{IHS}	2.0		3.5	V	1, 2
SDI Pulldown Resistor		R_{SDI}	25		60	k Ω	

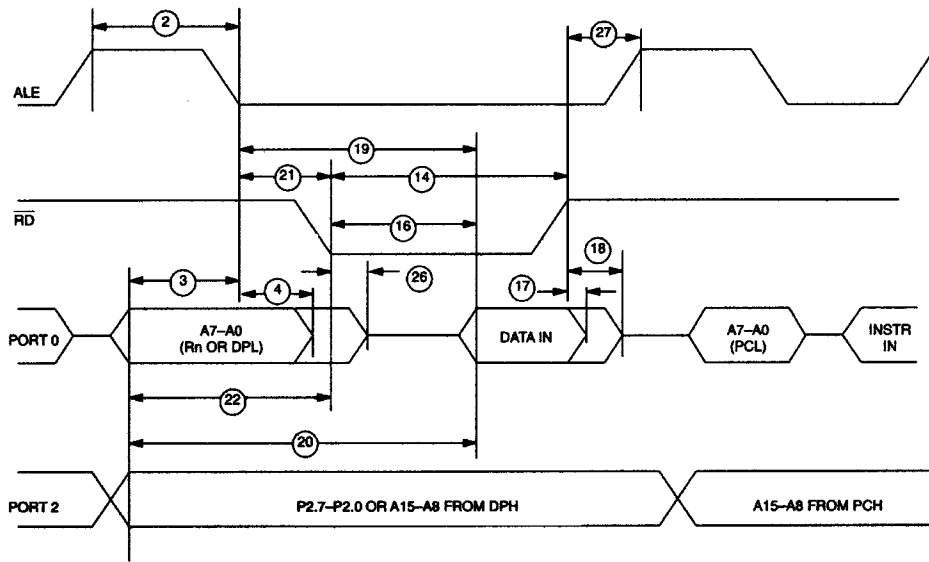
AC CHARACTERISTICS $(V_{CC} = 0V \text{ to } 5V, T_A = 0^\circ C \text{ to } +70^\circ C.)$

PARAMETER		SYMBOL	MIN	TYP	MAX	UNITS	NOTES
SDI Pulse Reject	$(4.5V < V_{CC} < 5.5V)$	t_{SPR}			2	μs	10
	$(V_{CC} = 0V, V_{BAT} = 2.9V)$				4		
SDI Pulse Accept	$(4.5V < V_{CC} < 5.5V)$	t_{SPA}	10			μs	10
	$(V_{CC} = 0V, V_{BAT} = 2.9V)$		50				

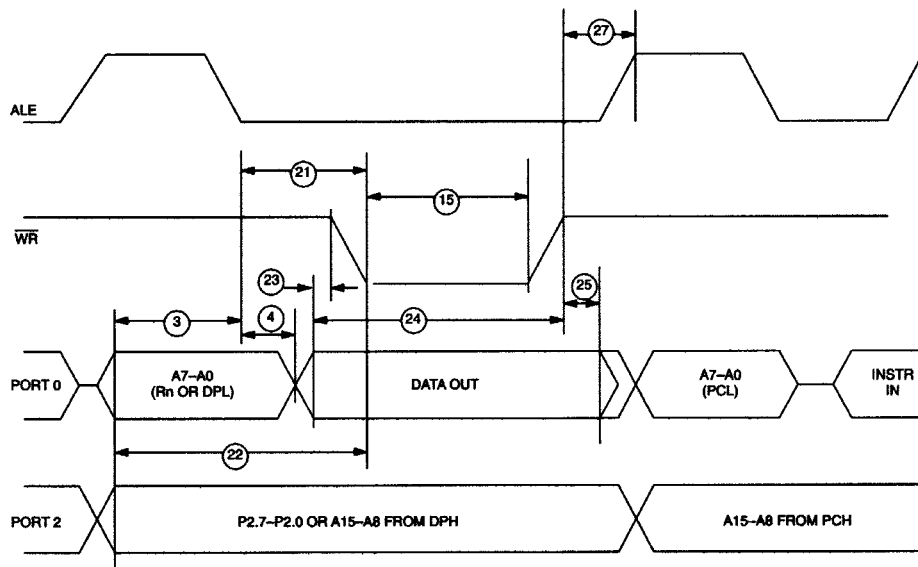
AC CHARACTERISTICS—EXPANDED BUS MODE TIMING SPECIFICATIONS $(V_{CC} = 5V \pm 10\%, T_A = 0^\circ C \text{ to } +70^\circ C.)$

#	PARAMETER	SYMBOL	MIN	MAX	UNITS
1	Oscillator Frequency	$1/t_{CLK}$	1.0	16 (-16)	MHz
2	ALE Pulse Width	t_{ALPW}	$2t_{CLK} - 40$		ns
3	Address Valid to ALE Low	t_{AVALL}	$t_{CLK} - 40$		ns
4	Address Hold After ALE Low	t_{AVAAV}	$t_{CLK} - 35$		ns
14	\overline{RD} Pulse Width	t_{RDPW}	$6t_{CLK} - 100$		ns
15	\overline{WR} Pulse Width	t_{WRPW}	$6t_{CLK} - 100$		ns
16	\overline{RD} Low to Valid Data In	At 12MHz		$5t_{CLK} - 165$	ns
		At 16MHz		$5t_{CLK} - 105$	
17	Data Hold after \overline{RD} High	t_{RDHDV}	0		ns
18	Data Float after \overline{RD} High	t_{RDHDZ}		$2t_{CLK} - 70$	ns
19	ALE Low to Valid Data In	At 12MHz		$8t_{CLK} - 150$	ns
		At 16MHz		$8t_{CLK} - 90$	
20	Valid Address to Valid Data In	At 12MHz		$9t_{CLK} - 165$	ns
		At 16MHz		$9t_{CLK} - 105$	
21	ALE Low to \overline{RD} or \overline{WR} Low	t_{ALLRDL}	$3t_{CLK} - 50$	$3t_{CLK} + 50$	ns
22	Address Valid to \overline{RD} or \overline{WR} Low	t_{AVRDL}	$4t_{CLK} - 130$		ns
23	Data Valid to \overline{WR} Going Low	t_{DVWRL}	$t_{CLK} - 60$		ns
24	Data Valid to \overline{WR} High	At 12MHz	$7t_{CLK} - 150$		ns
		At 16MHz	$7t_{CLK} - 90$		
25	Data Valid after \overline{WR} High	t_{WRHDV}	$t_{CLK} - 50$		ns
26	\overline{RD} Low to Address Float	t_{RDLAZ}		0	ns
27	\overline{RD} or \overline{WR} High to ALE High	t_{RDHALH}	$t_{CLK} - 40$	$t_{CLK} + 50$	ns

EXPANDED DATA MEMORY READ CYCLE

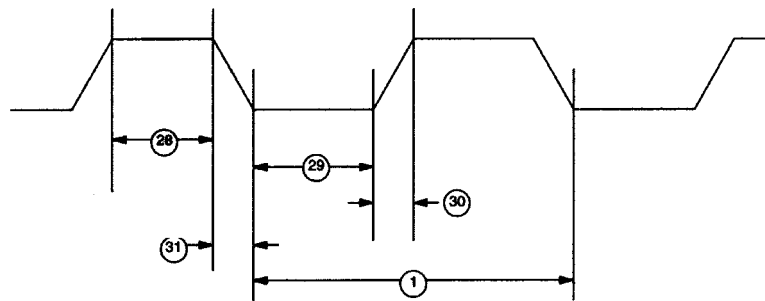


EXPANDED DATA MEMORY WRITE CYCLE



AC CHARACTERISTICS—EXTERNAL CLOCK DRIVE(V_{CC} = 5V ±10%, T_A = 0°C to +70°C.)

#	PARAMETER		SYMBOL	MIN	MAX	UNITS
28	External Clock High Time	At 12MHz	t _{CLKHPW}	20		ns
		At 16MHz		15		
29	External Clock Low Time	At 12MHz	t _{CLKLPW}	20		ns
		At 16MHz		15		
30	External Clock Rise Time	At 12MHz	t _{CLKR}		20	ns
		At 16MHz			15	
31	External Clock Fall Time	At 12MHz	t _{CLKF}		20	ns
		At 16MHz			15	

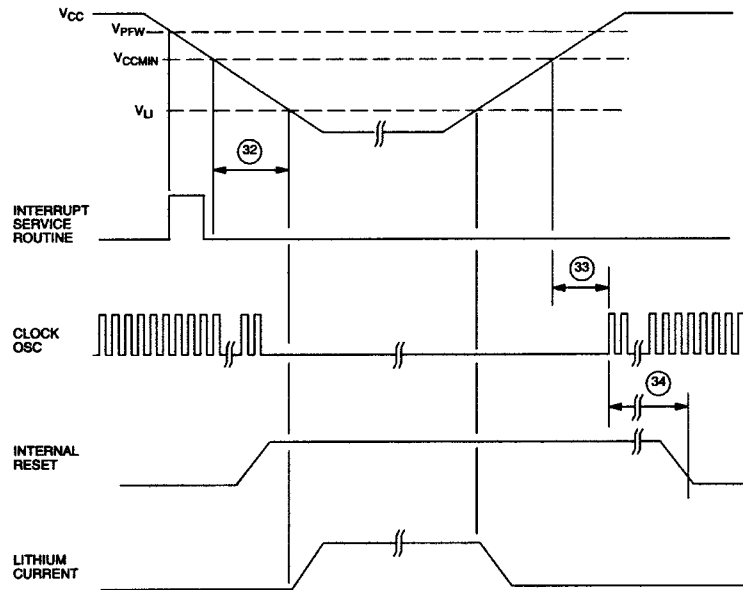
EXTERNAL CLOCK TIMING

AC CHARACTERISTICS—POWER CYCLE TIMING

($V_{CC} = 5V \pm 10\%$, $T_A = 0^\circ\text{C}$ to $+70^\circ\text{C}$.)

#	PARAMETER	SYMBOL	MIN	MAX	UNITS
32	Slew Rate from V_{CCMIN} to 3.3V	t_F	130		μs
33	Crystal Startup Time	t_{CSU}		(Note 8)	
34	Power-On Reset Delay	t_{POR}		21,504	t_{CLK}

POWER CYCLE TIMING

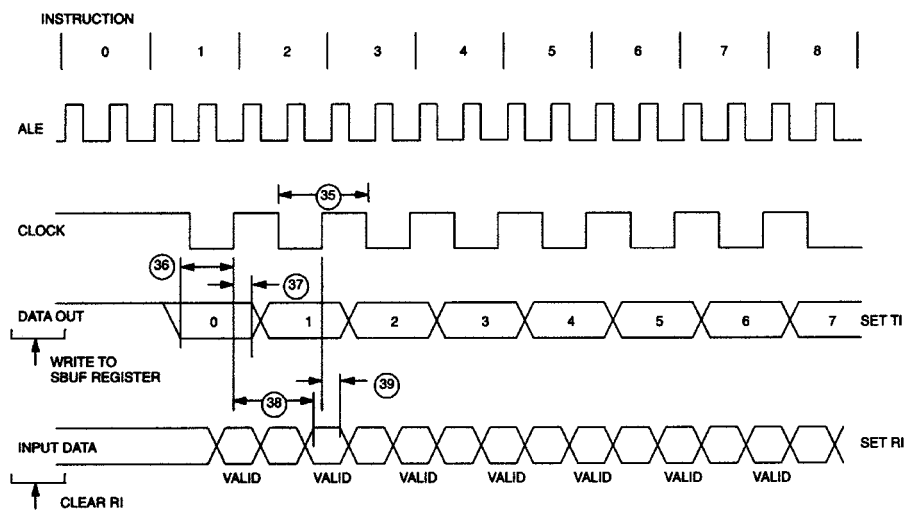


AC CHARACTERISTICS—SERIAL PORT TIMING: MODE 0

($V_{CC} = 5V \pm 10\%$, $T_A = 0^\circ\text{C}$ to $+70^\circ\text{C}$.)

#	PARAMETER	SYMBOL	MIN	MAX	UNITS
35	Serial Port Clock Cycle Time	t_{SPCLK}	$12t_{CLK}$		μs
36	Output Data Setup to Rising Clock Edge	t_{DOCH}	$10t_{CLK} - 133$		ns
37	Output Data Hold after Rising Clock Edge	t_{CHDO}	$2t_{CLK} - 117$		ns
38	Clock Rising Edge to Input Data Valid	t_{CHDV}		$10t_{CLK} - 133$	ns
39	Input Data Hold after Rising Clock Edge	t_{CHDIV}	0		ns

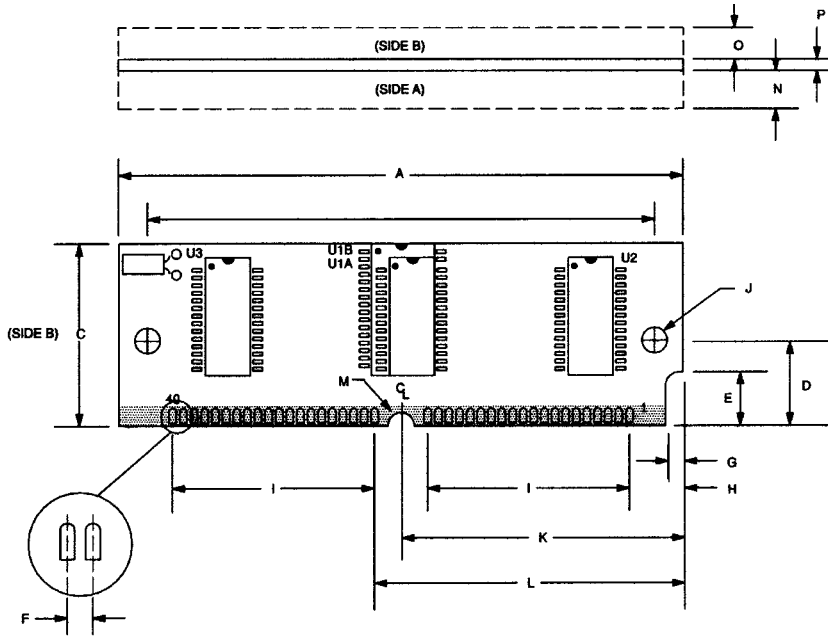
SERIAL PORT TIMING: MODE 0



NOTES:

- All voltage referenced to ground.
- SDI should be taken to a logic high when $V_{CC} = +5V$, and to approximately 3V when $V_{CC} < 3V$.
- SDI is deglitched to prevent accidental destruction. The pulse must be longer than t_{SPR} to pass the deglitcher, but SDI is not guaranteed unless it is longer than t_{SPA} .
- Maximum operating I_{CC} is measured with all output pins disconnected; XTAL1 driven with t_{CLKR} , $t_{CLKF} = 10$ ns, $V_{IL} = 0.5V$; XTAL2 disconnected; RST = PORT0 = V_{CC} .
- Idle mode I_{IDLE} is measured with all output pins disconnected; XTAL1 driven with t_{CLKR} , $t_{CLKF} = 10$ ns, $V_{IL} = 0.5V$; XTAL2 disconnected; PORT0 = V_{CC} , RST = V_{SS} .
- Stop mode I_{STOP} is measured with all output pins disconnected; PORT0 = V_{CC} ; XTAL2 not connected; RST = XTAL1 = V_{SS} .
- Pin capacitance is measured with a test frequency—1 MHz, $T_A = +25^\circ\text{C}$.
- Crystal startup time is the time required to get the mass of the crystal into vibrational motion from the time that power is first applied to the circuit until the first clock pulse is produced by the on-chip oscillator. The user should check with the crystal vendor for a worst-case specification on this time.

PACKAGE DRAWING



PKG DIM	INCHES	
	MIN	MAX
A	2.645	2.655
B	2.379	2.389
C	0.995	1.005
D	0.395	0.405
E	0.245	0.255
F	0.050 BSC	
G	0.075	0.085
H	0.245	0.255
I	0.950 BSC	
J	0.120	0.130
K	1.320	1.330
L	1.445	1.455
M	0.057	0.067
N	-	0.300
O	-	0.165
P	0.047	0.054

